

Notice of References Cited	Application/Control No. 10/576,766		Applicant(s)/Patent Under Reexamination OVEREND ET AL.	
	Examiner /Susan W. Berman/		Art Unit 1796	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,001,936	02-2006	Akers et al.	523/161
*	B	US-6,402,825	06-2002	Sun, Jing X	106/473
*	C	US-6,417,283	07-2002	Ikeda et al.	525/326.1
*	D	US-2003/0199612	10-2003	Nakajima, Atsushi	523/160
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.